

Notice of References Cited

Application/Control No.

Applicant(s)/Patent Under Reexamination
LEE, HYUN CHANG

Examiner

Kevin M. Nguyen

Applicant(s)/Patent Under Reexamination
LEE, HYUN CHANG

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,739,816	04-1998	Kobayashi et al.	345/204
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	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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